



ISO7230A ISO7231A

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# One Megabit per Second Triple Digital Isolators

Check for Samples: ISO7230A, ISO7231A

#### **FEATURES**

- 1Mbps Signaling Rate
  - Low Channel-to-Channel Output Skew;
     2ns Maximum (5V-Operation)
  - Low Pulse-Width Distortion (PWD);
     10ns Maximum (5V-Operation)
- Typical 25-Year Life at Rated Working Voltage (See Application note SLLA197 and Figure 10)
- 4000V<sub>peak</sub> Isolation, 560V<sub>peak</sub> V<sub>IORM</sub>
  - UL 1577, IEC 60747-5-2 (VDE 0884, Rev 2),
     IE 61010-1 and CSA Approved, IEC 60950-1
- 4kV ESD Protection
- Operate With 3.3V or 5V Supplies

- High Electromagnetic Immunity (See Application note SLLA181)
- –40°C to 125°C Operating Range

#### **APPLICATIONS**

- · Industrial Fieldbus
- Computer Peripheral Interface
- Servo Control Interface
- Data Acquisition

### **DESCRIPTION**

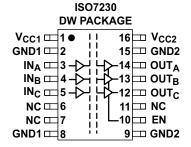
See the Product Notification section. The ISO7230A and ISO7231A are triple-channel digital isolators each with multiple channel configurations and output-enable functions. These devices have logic input and output buffers separated by Tl's silicon dioxide (SiO<sub>2</sub>) isolation barrier. Used in conjunction with isolated power supplies, these devices block high voltage, isolate grounds, and prevent noise currents on a data bus or other circuits from entering the local ground and interfering with or damaging sensitive circuitry.

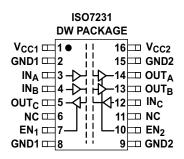
The ISO7230 triple-channel device has all three channels in the same direction while the ISO7231 has two channels in one direction and one channel in opposition. These devices have an active-high output enable that when driven to a low level, places the output in a high-impedance state.

The ISO7230A and ISO7231A have TTL input thresholds and a noise-filter at the input that prevents transient pulses of up to 2ns in duration from being passed to the output of the device.

In each device a periodic update pulse is sent across the isolation barrier to ensure the proper dc level of the output. If this dc-refresh pulse is not received, the input is assumed to be unpowered or not being actively driven, and the failsafe circuit drives the output to a logic high state. (Contact TI for a logic low failsafe option).

These devices require two supply voltages of 3.3V, 5V, or any combination. All inputs are 5V tolerant when supplied from a 3.3V supply and all outputs are 4mA CMOS. These devices are characterized for operation over the ambient temperature range of –40°C to 125°C.







Please be aware that an important notice concerning availability, standard warranty, and use in critical applications of Texas Instruments semiconductor products and disclaimers thereto appears at the end of this data sheet.

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This integrated circuit can be damaged by ESD. Texas Instruments recommends that all integrated circuits be handled with appropriate precautions. Failure to observe proper handling and installation procedures can cause damage.

ESD damage can range from subtle performance degradation to complete device failure. Precision integrated circuits may be more susceptible to damage because very small parametric changes could cause the device not to meet its published specifications.

#### **FUNCTION DIAGRAM**

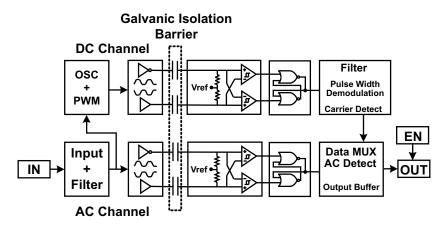


Table 1. Device Function Table ISO723x (1)

INPUT V <sub>CC</sub>	OUTPUT V <sub>CC</sub>	INPUT (IN)	OUTPUT ENABLE (EN)	OUTPUT (OUT)
		Н	H or Open	Н
DU	DII	L	H or Open	L
PU	PU	X	L	Z
		Open	H or Open	Н
PD	PU	Х	H or Open	Н
PD	PU	Х	L	Z

(1) PU = Powered Up; PD = Powered Down; X = Irrelevant; H = High Level; L = Low Level

### **AVAILABLE OPTIONS**

PRODUCT	SIGNALING RATE	INPUT THRESHOLD	CHANNEL CONFIGURATION	MARKED AS	ORDERING NUMBER <sup>(1)</sup>	
ISO7230ADW	1 Mbps	~1.5V (TTL) (CMOS compatible)	3/0	ISO7230A	ISO7230ADW (rail) ISO7230ADWR (reel)	
100-00115111		~1.5 V (TTL)		100=0011	ISO7230ADWR (reel)	
ISO7231ADW	1 Mbps	(CMOS compatible)	2/1	ISO7231A	ISO7231ADWR (reel)	

For the most current package and ordering information, see the Package Option Addendum at the end of this document, or see the TI website at www.ti.com.

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## **ABSOLUTE MAXIMUM RATINGS**(1)

					VALUE	UNIT
$V_{CC}$	Supply voltag	je <sup>(2)</sup> , V <sub>CC1</sub> , V <sub>CC2</sub>			-0.5 to 6	V
$V_{I}$	Voltage at IN	, OUT, EN			-0.5 to 6	V
Io	Output current					mA
		Human Body Model	JEDEC Standard 22, Test Method A114-C.01		±4	
ESD	Electrostatic discharge	Field-Induced-Charged Device Model	JEDEC Standard 22, Test Method C101	All pins	±1	kV
		Machine Model	ANSI/ESDS5.2-1996		±200	V
$T_{J}$	Maximum junction temperature					°C

Stresses beyond those listed under absolute maximum ratings may cause permanent damage to the device. These are stress ratings only and functional operation of the device at these or any other conditions beyond those indicated under recommended operating conditions is not implied. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.

#### RECOMMENDED OPERATING CONDITIONS

		MIN	TYP	MAX	UNIT
$V_{CC}$	Supply voltage <sup>(1)</sup> , V <sub>CC1</sub> , V <sub>CC2</sub>	3.15		5.5	٧
I <sub>OH</sub>	High-level output current	-4			mA
$I_{OL}$	Low-level output current			4	mA
t <sub>ui</sub>	Input pulse width	1			μs
1/t <sub>ui</sub>	Signaling rate	0	1500 <sup>(2)</sup>	1000	kbps
$V_{IH}$	High-level input voltage (IN) (EN on all devices)	2		$V_{CC}$	V
$V_{IL}$	Low-level input voltage (IN) (EN on all devices)	0		0.8	V
$T_{J}$	Junction temperature			150	°C
Н	External magnetic field-strength immunity per IEC 61000-4-8 and IEC 61000-4-9 certification			1000	A/m

For the 5V operation,  $V_{\text{CC1}}$  or  $V_{\text{CC2}}$  is specified from 4.5V to 5.5V. For the 3V operation,  $V_{CC1}$  or  $V_{CC2}$  is specified from 3.15V to 3.6V. Typical signaling rate under ideal conditions at 25°C.

All voltage values are with respect to network ground terminal and are peak voltage values.

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# ELECTRICAL CHARACTERISTICS: V<sub>CC1</sub> and V<sub>CC2</sub> at 5V<sup>(1)</sup> OPERATION

over recommended operating conditions (unless otherwise noted)

	PARAMETER		TEST CONDITIONS	MIN	TYP	MAX	UNIT
SUPPLY	CURRENT						
	10070004	Quiescent	V <sub>I</sub> = V <sub>CC</sub> or 0V, All channels, no load,		1	3	A
	ISO7230A	1 Mbps	EN <sub>2</sub> at 3V		1	3	mA
I <sub>CC1</sub>	1007004 A	Quiescent	V <sub>I</sub> = V <sub>CC</sub> or 0V, All channels, no load,		6.5	11	A
	ISO7231A	1 Mbps	EN <sub>1</sub> at 3V, EN <sub>2</sub> at 3V		6.5	11	mA
	10072204	Quiescent	V <sub>I</sub> = V <sub>CC</sub> or 0V, All channels, no load,		15	22	A
lcca	ISO7230A	1 Mbps	EN <sub>2</sub> at 3V		16	22	mA
I <sub>CC2</sub>	ISO7231A	Quiescent	V <sub>I</sub> = V <sub>CC</sub> or 0V, All channels, no load,		13	20	A
	1507231A	1 Mbps	EN <sub>1</sub> at 3V, EN <sub>2</sub> at 3V		13	20	mA
ELECTR	RICAL CHARACTERISTIC	s					
I <sub>OFF</sub>	Sleep mode output curr	ent	EN at 0V, Single channel		0		μΑ
1/	High-level output voltag	10	I <sub>OH</sub> = -4mA, See Figure 1	$V_{CC} - 0.8$	V <sub>CC</sub> - 0.8 V <sub>CC</sub> - 0.1		V
V <sub>OH</sub>	r light-level output voltag	j <del>e</del>	$I_{OH} = -20\mu A$ , See Figure 1	$V_{CC} - 0.1$			V
1/	Low-level output voltage	•	I <sub>OL</sub> = 4mA, See Figure 1			0.4	V
V <sub>OL</sub>	Low-level output voltage	<b>5</b>	I <sub>OL</sub> = 20μA, See Figure 1		0.1		V
$V_{I(HYS)}$	Input voltage hysteresis	3			150		mV
I <sub>IH</sub>	High-level input current		IN from 0V to V <sub>CC</sub>			10	
$I_{\text{IL}}$	Low-level input current		IIA HOHLOA TO ACC	-10			μA
C <sub>I</sub>	Input capacitance to gro	ound	IN at $V_{CC}$ , $V_{I} = 0.4 \sin (4E6\pi t)$		2		pF
CMTI	Common-mode transier	nt immunity	V <sub>I</sub> = V <sub>CC</sub> or 0V, See Figure 4	25	50		kV/µs

For the 5V operation,  $V_{CC1}$  or  $V_{CC2}$  is specified from 4.5V to 5.5V. For the 3V operation,  $V_{CC1}$  or  $V_{CC2}$  is specified from 3.15V to 3.6V.

# SWITCHING CHARACTERISTICS: $V_{CC1}$ and $V_{CC2}$ at 5V OPERATION

	PARAMETER	TEST CONDITIONS	MIN	TYP	MAX	UNIT
t <sub>PLH</sub> , t <sub>PHL</sub>	Propagation delay	San Figure 4	40		95	
PWD	Pulse-width distortion <sup>(1)</sup>  t <sub>PHL</sub> - t <sub>PLH</sub>	See Figure 1			10	ns
t <sub>sk(o)</sub>	Channel-to-channel output skew (2)			0	2	ns
t <sub>r</sub>	Output signal rise time	San Figure 4		2	20	
t <sub>f</sub>	Output signal fall time	See Figure 1		2		ns
t <sub>PHZ</sub>	Propagation delay, high-level-to-high-impedance output			15	20	
t <sub>PZH</sub>	Propagation delay, high-impedance-to-high-level output	See Figure 2		15	20	
$t_{PLZ}$	Propagation delay, low-level-to-high-impedance output	See Figure 2		15	20	ns
t <sub>PZL</sub>	Propagation delay, high-impedance-to-low-level output			15	20	
t <sub>fs</sub>	Failsafe output delay time from input power loss	See Figure 3		12		μs

Also referred to as pulse skew.

t<sub>sk(o)</sub> is the skew between specified outputs of a single device with all driving inputs connected together and the outputs switching in the same direction while driving identical specified loads.

ISO7230A ISO7231A

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# ELECTRICAL CHARACTERISTICS: V<sub>CC1</sub> at 5V, V<sub>CC2</sub> at 3.3V<sup>(1)</sup> OPERATION

over recommended operating conditions (unless otherwise noted)

	PARAMET	ER	TEST CONDITION	S	MIN	TYP	MAX	UNIT
SUPPLY	CURRENT							
	ISO7230A	Quiescent	// // or O// All shannels no lo	ad FN at 21/		1	3	m Λ
	1507230A	1 Mbps	$V_I = V_{CC}$ or 0V, All channels, no loa	ad, EN <sub>2</sub> at 3V		1	3	mA
I <sub>CC1</sub>	1007004 A	Quiescent	V <sub>I</sub> = V <sub>CC</sub> or 0V, All channels, no loa	ad, EN₁ at 3V,		6.5	11	Λ
	ISO7231A	1 Mbps	EN <sub>2</sub> at 3V			6.5	11	mA
	10070004	Quiescent	)/	TN -+ 2\/		9	15	Λ
	ISO7230A	1 Mbps	$V_I = V_{CC}$ or 0V, All channels, no loa	ad, EN <sub>2</sub> at 3V		9.5	15	mA
$I_{CC2}$	1007004 A	Quiescent	V <sub>I</sub> = V <sub>CC</sub> or 0V, All channels, no loa	ad, EN₁ at 3V,		8	12	Λ
	ISO7231A	1 Mbps	EN <sub>2</sub> at 3V			8	12	mA
ELECTR	RICAL CHARACTI	ERISTICS						
I <sub>OFF</sub>	Sleep mode ou	tput current	EN at 0 V, Single channel			0		μA
				ISO7230	V <sub>CC</sub> - 0.4			
$V_{OH}$	High-level outp	ut voltage	I <sub>OH</sub> = -4mA, See Figure 1	ISO7231 (5-V side)	V <sub>CC</sub> - 0.8			V
			I <sub>OH</sub> = –20μA, See Figure 1		V <sub>CC</sub> - 0.1			
\ /	I avvilaval avvia	st coalta na	I <sub>OL</sub> = 4mA, See Figure 1	I <sub>OL</sub> = 4mA, See Figure 1			0.4	V
$V_{OL}$	Low-level outpu	ut voltage	I <sub>OL</sub> = 20μA, See Figure 1				0.1	V
V <sub>I(HYS)</sub>	Input voltage h	ysteresis				150		mV
I <sub>IH</sub>	High-level input	t current	IN from 0\/ to \/				10	
I <sub>IL</sub>	Low-level input	current	IN from 0V to V <sub>CC</sub>		-10			μA
Cı	Input capacitan	ce to ground	IN at $V_{CC}$ , $V_{I} = 0.4 \sin (4E6\pi t)$			2		pF
CMTI	Common-mode immunity	transient	V <sub>I</sub> = V <sub>CC</sub> or 0 V, See Figure 4		25	50		kV/µs

<sup>(1)</sup> For the 5-V operation,  $V_{CC1}$  or  $V_{CC2}$  is specified from 4.5V to 5.5V. For the 3V operation,  $V_{CC1}$  or  $V_{CC2}$  is specified from 3.15 V to 3.6 V.

# SWITCHING CHARACTERISTICS: V<sub>CC1</sub> at 5V, V<sub>CC2</sub> at 3.3V OPERATION

	PARAMETER		TEST CONDITIONS	MIN	TYP	MAX	UNIT
t <sub>PLH</sub> , t <sub>PHL</sub>	Propagation delay, low-to-high-level output	ISO723xA	Coo Figure 4	40		100	
PWD	Pulse-width distortion <sup>(1)</sup>  t <sub>PHL</sub> - t <sub>PLH</sub>	150723XA	See Figure 1			11	ns
t <sub>sk(o)</sub>	Channel-to-channel output skew (2)	ISO723xA			0	2.5	ns
t <sub>r</sub>	Output signal rise time		Coo Figure 4		2		ns
t <sub>f</sub>	Output signal fall time		See Figure 1		2		
t <sub>PHZ</sub>	Propagation delay, high-level-to-high-impeda	nce output			15	20	
t <sub>PZH</sub>	Propagation delay, high-impedance-to-high-le	evel output	Soo Figure 2		15	20	
$t_{PLZ}$	Propagation delay, low-level-to-high-impedance output		See Figure 2		15	20	ns
t <sub>PZL</sub>	Propagation delay, high-impedance-to-low-le	vel output			15	20	
t <sub>fs</sub>	Failsafe output delay time from input power lo	oss	See Figure 3		18		μs

<sup>(1)</sup> Also known as pulse skew

<sup>(2)</sup> t<sub>sk(0)</sub> is the skew between specified outputs of a single device with all driving inputs connected together and the outputs switching in the same direction while driving identical specified loads.

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# ELECTRICAL CHARACTERISTICS: V<sub>CC1</sub> at 3.3V, V<sub>CC2</sub> at 5V<sup>(1)</sup> OPERATION

over recommended operating conditions (unless otherwise noted)

	PARAMET	ER	TEST CONDITION	S	MIN	TYP	MAX	UNIT
SUPPLY	CURRENT							
	10070004	Quiescent	)/	- 1 EN -1 OV		0.5	1	^
	ISO7230A	1 Mbps	$V_I = V_{CC}$ or 0V, All channels, no loa	ad, EN <sub>2</sub> at 3V		1	2	mA
I <sub>CC1</sub>	1007004 A	Quiescent	V <sub>I</sub> = V <sub>CC</sub> or 0V, All channels, no loa	ad, EN₁ at 3V,		4.5	7	A
	ISO7231A	1 Mbps	EN <sub>2</sub> at 3V			4.5	7	mA
	ISO7230A	Quiescent	// // or O// All abannala na lac	od EN at 2\/		15	22	A
	1507230A	1 Mbps	$V_1 = V_{CC}$ of $UV$ , All channels, no los	$V_1 = V_{CC}$ or 0V, All channels, no load, EN <sub>2</sub> at 3V			22	mA
I <sub>CC2</sub>	ISO7231A	Quiescent	V <sub>I</sub> = V <sub>CC</sub> or 0V, All channels, no loa	ad, EN <sub>1</sub> at 3V,		13	20	mΛ
	1507231A	1 Mbps	EN <sub>2</sub> at 3V			13	20	mA
ELECTR	RICAL CHARACTI	ERISTICS						
I <sub>OFF</sub>	Sleep mode ou	tput current	EN at 0V, Single channel			0		μΑ
				ISO7230	V <sub>CC</sub> - 0.4			
$V_{OH}$	High-level outp	ut voltage	$I_{OH} = -4$ mA, See Figure 1 ISO7231 (5-V side)		V <sub>CC</sub> - 0.8			V
			$I_{OH} = -20\mu A$ , See Figure 1		V <sub>CC</sub> - 0.1			
V	Low-level outpu	ıt voltogo	I <sub>OL</sub> = 4mA, See Figure 1				0.4	V
V <sub>OL</sub>	Low-level outpo	it voltage	I <sub>OL</sub> = 20μA, See Figure 1			0.1	V	
$V_{I(HYS)}$	Input voltage hy	ysteresis				150		mV
I <sub>IH</sub>	High-level input	t current	INI from OV/ to V/				10	
I <sub>IL</sub>	Low-level input	current	IN from 0V to V <sub>CC</sub>		-10			μA
Cı	Input capacitan	ce to ground	IN at $V_{CC}$ , $V_{I} = 0.4 \sin (4E6\pi t)$			2		pF
CMTI	Common-mode immunity	transient	V <sub>I</sub> = V <sub>CC</sub> or 0V, See Figure 4		25	50		kV/μs

<sup>(1)</sup> For 5V operation,  $V_{CC1}$  or  $V_{CC2}$  is specified from 4.5V to 5.5V. For 3V operation,  $V_{CC1}$  or  $V_{CC2}$  is specified from 3.15V to 3.6V.

## SWITCHING CHARACTERISTICS: $V_{CC1}$ at 3.3V and $V_{CC2}$ at 5V OPERATION

	PARAMETER		TEST CONDITIONS	MIN	TYP	MAX	UNIT
t <sub>PLH</sub> , t <sub>PHL</sub>	Propagation delay	1007004	Con Figure 4	40		100	
PWD	Pulse-width distortion <sup>(1)</sup>  t <sub>PHL</sub> - t <sub>PLH</sub>	ISO723xA	See Figure 1			11	ns
t <sub>sk(o)</sub>	Channel-to-channel output skew (2)	ISO723xA			0	2.5	ns
t <sub>r</sub>	Output signal rise time	·	Con Figure 4		2		
t <sub>f</sub>	Output signal fall time		See Figure 1		2		ns
t <sub>PHZ</sub>	Propagation delay, high-level-to-high-impe	edance output			15	20	
t <sub>PZH</sub>	Propagation delay, high-impedance-to-hig	h-level output	Con Firmer C		15	20	
t <sub>PLZ</sub>	Propagation delay, low-level-to-high-impedance output		See Figure 2		15	20	ns
t <sub>PZL</sub>	Propagation delay, high-impedance-to-low	v-level output			15	20	
t <sub>fs</sub>	Failsafe output delay time from input power loss		See Figure 3		12		μs

<sup>(1)</sup> Also known as pulse skew

 $t_{sk(o)}$  is the skew between specified outputs of a single device with all driving inputs connected together and the outputs switching in the same direction while driving identical specified loads.

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# ELECTRICAL CHARACTERISTICS: V<sub>CC1</sub> and V<sub>CC2</sub> at 3.3V<sup>(1)</sup> OPERATION

over recommended operating conditions (unless otherwise noted)

	PARAMETER		TEST CONDITIONS	MIN	TYP	MAX	UNIT
SUPPLY	CURRENT					,	
	10070004	Quiescent	V <sub>I</sub> = V <sub>CC</sub> or 0 V, all channels, no load,		0.5	1	^
	ISO7230A	1 Mbps	EN <sub>2</sub> at 3V		1	2	mA
I <sub>CC1</sub>	10070044	Quiescent	V <sub>I</sub> = V <sub>CC</sub> or 0V, all channels, no load,		4.5	7	^
	ISO7231A	1 Mbps	EN <sub>1</sub> at 3V, EN <sub>2</sub> at 3V		4.5	7	mA
	ISO7230A	Quiescent	V <sub>I</sub> = V <sub>CC</sub> or 0V, all channels, no load,		9	15	^
	1301230A	1 Mbps	EN <sub>2</sub> at 3V		9.5	15	mA
I <sub>CC2</sub>	ISO7231A	Quiescent	V <sub>I</sub> = V <sub>CC</sub> or 0V, all channels, no load,		8	12	A
	1507231A	1 Mbps	EN <sub>1</sub> at 3V, EN <sub>2</sub> at 3V		8	12	mA
ELECTR	ICAL CHARACTERISTICS	•		•			
I <sub>OFF</sub>	Sleep mode output current		EN at 0V, single channel		0		μΑ
\/	High-level output voltage		I <sub>OH</sub> = -4mA, See Figure 1	V <sub>CC</sub> - 0.4	V <sub>CC</sub> - 0.4 V <sub>CC</sub> - 0.1		V
V <sub>OH</sub>	nigii-ievei output voitage		$I_{OH} = -20\mu A$ , See Figure 1	V <sub>CC</sub> - 0.1			V
.,	Low lovel output voltage		I <sub>OL</sub> = 4mA, See Figure 1			0.4	V
$V_{OL}$	Low-level output voltage		I <sub>OL</sub> = 20μA, See Figure 1			0.1	V
$V_{I(HYS)}$	Input voltage hysteresis				150		mV
I <sub>IH</sub>	High-level input current		INI from OV or V			10	
I <sub>IL</sub>	Low-level input current		IN from 0V or V <sub>CC</sub>	-10			μA
Cı	Input capacitance to ground		IN at V <sub>CC</sub> , V <sub>I</sub> = 0.4 sin (4E6πt)		2		pF
CMTI	Common-mode transient imn	nunity	V <sub>I</sub> = V <sub>CC</sub> or 0V, See Figure 4	25	50		kV/µs

<sup>(1)</sup> For 5V operation,  $V_{CC1}$  or  $V_{CC2}$  is specified from 4.5V to 5.5V. For 3V operation,  $V_{CC1}$  or  $V_{CC2}$  is specified from 3.15V to 3.6V.

# SWITCHING CHARACTERISTICS: $V_{CC1}$ and $V_{CC2}$ at 3.3-V OPERATION

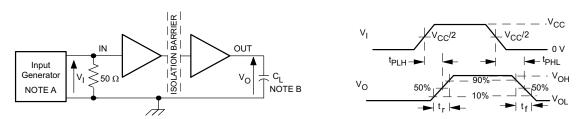
	PARAMETER		TEST CONDITIONS	MIN	TYP	MAX	UNIT
t <sub>PLH</sub> , t <sub>PHL</sub>	Propagation delay	1007004	Con Figure 4	45		110	
PWD	Pulse-width distortion <sup>(1)</sup>  t <sub>PHL</sub> - t <sub>PLH</sub>	ISO723xA	See Figure 1			12	ns
t <sub>sk(o)</sub>	Channel-to-channel output skew (2)	ISO723xA			0	3	ns
t <sub>r</sub>	Output signal rise time		0 5 4		2		
t <sub>f</sub>	Output signal fall time		See Figure 1		2		ns
t <sub>PHZ</sub>	Propagation delay, high-level-to-high-im	pedance output			15	20	
t <sub>PZH</sub>	Propagation delay, high-impedance-to-h	igh-level output			15	20	
t <sub>PLZ</sub>	Propagation delay, low-level-to-high-imp	edance output	e output See Figure 2		15	20	ns
t <sub>PZL</sub>	Propagation delay, high-impedance-to-lo	ow-level output			15	20	
t <sub>fs</sub>	Failsafe output delay time from input po	wer loss	See Figure 3		18		μs

<sup>(1)</sup> Also referred to as pulse skew.

<sup>(</sup>z) t<sub>sk(o)</sub> is the skew between specified outputs of a single device with all driving inputs connected together and the outputs switching in the same direction while driving identical specified loads.

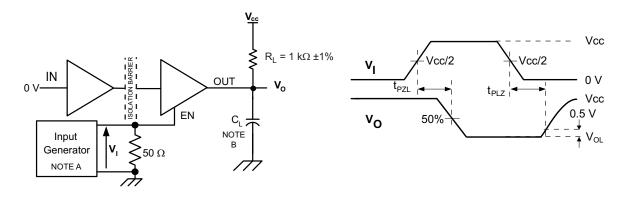


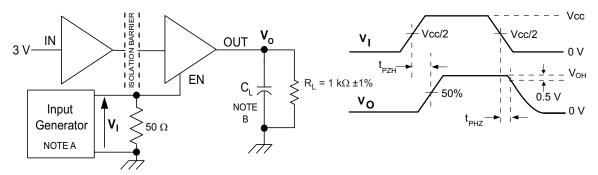
#### PARAMETER MEASUREMENT INFORMATION



- A. The input pulse is supplied by a generator having the following characteristics: PRR  $\leq$  50kHz, 50% duty cycle,  $t_r \leq$  3ns,  $t_f \leq$  3ns,  $Z_O = 50\Omega$ .
- B.  $C_L = 15$  pF and includes instrumentation and fixture capacitance within  $\pm 20\%$ .

Figure 1. Switching Characteristic Test Circuit and Voltage Waveforms



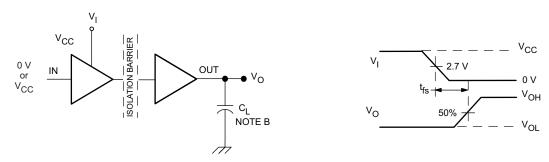


- A. The input pulse is supplied by a generator having the following characteristics: PRR  $\leq$  50kHz, 50% duty cycle,  $t_r \leq$  3ns,  $t_f \leq$  3ns,  $Z_O = 50\Omega$ .
- B.  $C_L = 15$  pF and includes instrumentation and fixture capacitance within  $\pm 20\%$ .

Figure 2. Enable/Disable Propagation Delay Time Test Circuit and Waveform

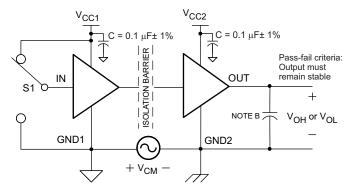
INSTRUMENTS

## PARAMETER MEASUREMENT INFORMATION (continued)



- A. The input pulse is supplied by a generator having the following characteristics: PRR  $\leq$  50kHz, 50% duty cycle,  $t_r \leq$  3ns,  $t_f \leq$  3ns,  $Z_O = 50\Omega$ .
- B.  $C_L = 15pF$  and includes instrumentation and fixture capacitance within  $\pm 20\%$ .

Figure 3. Failsafe Delay Time Test Circuit and Voltage Waveforms



- A. The input pulse is supplied by a generator having the following characteristics: PRR  $\leq$  50kHz, 50% duty cycle,  $t_r \leq$  3ns,  $t_f \leq$  3ns,  $Z_O = 50\Omega$ .
- B.  $C_L = 15 \text{ pF}$  and includes instrumentation and fixture capacitance within  $\pm 20\%$ .

Figure 4. Common-Mode Transient Immunity Test Circuit and Voltage Waveform

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## **DEVICE INFORMATION**

## **PACKAGE CHARACTERISTICS**

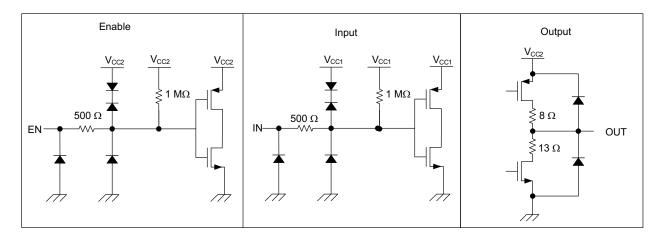
	PARAMETER	TEST CONDITIONS	MIN	TYP	MAX	UNIT
L(I01)	Minimum air gap (Clearance)	Shortest terminal-to-terminal distance through air	8.34			mm
L(I02)	Minimum external tracking (Creepage)	Shortest terminal-to-terminal distance across the package surface	8.1			mm
	Minimum Internal Gap (Internal Clearance)	Distance through the insulation	0.008			mm
R <sub>IO</sub> Isolation resistance		Input to output, $V_{IO}$ = 500V, all pins on each side of the barrier tied together creating a two-terminal device, $T_A$ < 100°C		>10 <sup>12</sup>		Ω
		Input to output, $V_{IO} = 500V$ , $100^{\circ}C \le T_A \le T_A$ max		>10 <sup>11</sup>		Ω
C <sub>IO</sub>	Barrier capacitance Input to output	$V_1 = 0.4 \sin (4E6\pi t)$		2		pF
Cı	Input capacitance to ground	$V_1 = 0.4 \sin (4E6\pi t)$		2		pF

## **REGULATORY INFORMATION**

VDE	CSA	UL
Certified according to IEC 60747-5-2	Approved under CSA Component Acceptance Notice	Recognized under 1577 Component Recognition Program <sup>(1)</sup>
File Number: 40016131	File Number: 220991	File Number: E181974

<sup>(1)</sup> Production tested ≥ 3000 VRMS for 1 second in accordance with UL 1577.

# **DEVICE I/O SCHEMATICS**





#### THERMAL CHARACTERISTICS

over recommended operating conditions (unless otherwise noted)

	PARAMETER	PARAMETER TEST CONDITIONS				UNIT
0	lunation to air	Low-K Thermal Resistance <sup>(1)</sup>		168		°C/W
$\theta_{JA}$	Junction-to-air	High-K Thermal Resistance		96.1		C/VV
$\theta_{JB}$	Junction-to-Board Thermal Resistance			61		°C/W
$\theta_{JC}$	Junction-to-Case Thermal Resistance			48		°C/W
$P_D$	Device Power Dissipation	$V_{CC1} = V_{CC2} = 5.5 \text{ V}, T_J = 150^{\circ}\text{C}, C_L = 15 \text{ pF},$ Input a 50% duty cycle square wave			220	mW

(1) Tested in accordance with the Low-K or High-K thermal metric definitions of EIA/JESD51-3 for leaded surface mount packages.

## TYPICAL CHARACTERISTIC CURVES

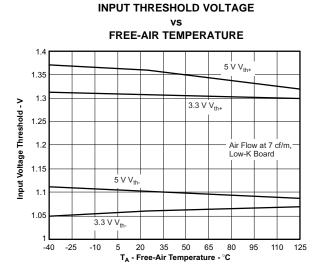
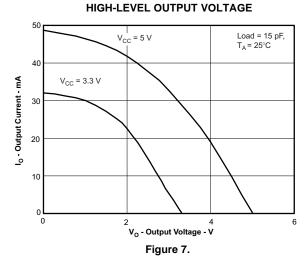


Figure 5.

# HIGH-LEVEL OUTPUT CURRENT vs



#### V<sub>CC1</sub> FAILSAFE THRESHOLD vs FREE-AIR TEMPERATURE

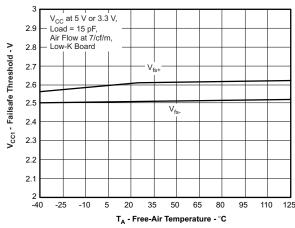


Figure 6.

# LOW-LEVEL OUTPUT CURRENT vs LOW-LEVEL OUTPUT VOLTAGE

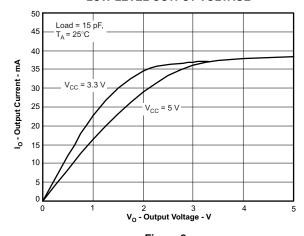


Figure 8.



#### **APPLICATION INFORMATION**

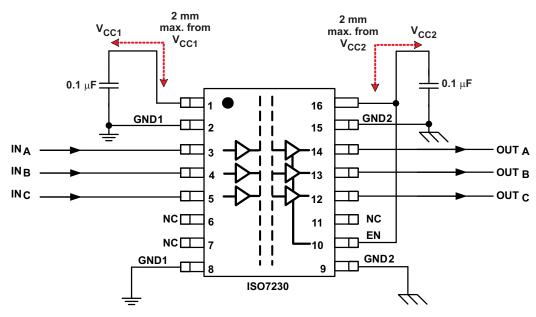


Figure 9. Typical ISO7230 Application Circuit

## LIFE EXPECTANCY vs WORKING VOLTAGE

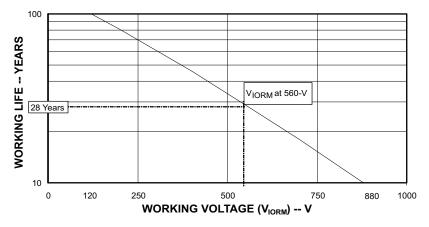


Figure 10. Time Dependant Dielectric Breakdown Testing Results

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#### PRODUCT NOTIFICATION

**INSTRUMENTS** 

An ISO723xA anomaly occurs when a negative-going pulse below the specified 1µs minimum bit width is input to the device. The output locks in a logic-low condition until the next rising edge occurs after a 1µs period.

Positive noise edges in pulses of less than the minimum specified 1µs have no effect on the device, and are properly filtered.

To prevent noise from interfering with ISO723xA performance, it is recommended that an appropriately sized capacitor be placed on each input of the device

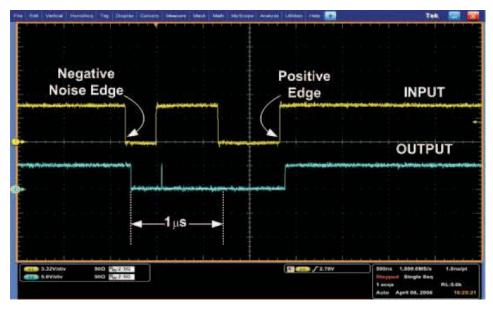


Figure 11. ISO723xA Anomaly

TEXAS INSTRUMENTS

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# **REVISION HISTORY**

	Cł	nanges from Original (May 2008) to Revision A	Page
Deleted Product Preview note       2         C Changed Voc From: 3 for 3.45       3         Changed Voc From: 3.6 To: 3.45       3         Changed Voc − 0.4 To: Voc − 0.8       4         C Changed Typical value from 1 To: 2       4         C Changed Propagation delay max From: 80 To: 95       4         C Changed Propagation delay max From: 80 To: 95       4         C Changed Propagation delay max From: 80 To: 100       5         C Changed Typical value from 1 To: 2       5         C Changed Typical value from 1 To: 2       5         C Changed Propagation delay max From: 80 To: 100       5         C Changed Propagation delay max From: 80 To: 100       5         C Changed Propagation delay max From: 80 To: 100       6         C Changed Propagation delay max From: 80 To: 100       6         C Changed Typical value from 1 To: 2       6         C Changed Typical value from 1 To: 2       7         C Changed Propagation delay max From: 85 To: 110       7         C Changed Typical value from 1 To: 2       7         C Changed Typical value from 1 To: 2       7         C Changed Typical value from 1 To: 2       10         C Changed Typical value from 1 To: 2       10         C Changed Typical value from 1 To: 2       10         C Cha	•	Added Product Notification section link.	1
Changed From: 3 To: 3.15 Changed V <sub>CO</sub> From: 3.6 To: 3.45 Changed V <sub>CO</sub> From: 3.6 To: 3.45 Changed V <sub>CO</sub> = not I <sub>CCZ</sub> values From: TBD Changed V <sub>CO</sub> = 0.4 To: V <sub>CC</sub> = 0.8 Changed Typical value from 1 To: 2 Changed Typical value from 1 To: 2 Changed Typical value from 1 To: 2 Changed I <sub>CCI</sub> and I <sub>CCZ</sub> values From: 80 To: 95 Changed I <sub>CCI</sub> and I <sub>CCZ</sub> values From: BD Changed Typical value from 1 To: 2 Changed Typical value from 1 To: 2 Changed Propagation delay max From: 80 To: 100 Changed I <sub>CCI</sub> and I <sub>CCZ</sub> values From: BD Changed I <sub>CCI</sub> and I <sub>CCZ</sub> values From: BD Changed I <sub>CCI</sub> and I <sub>CCZ</sub> values From: BD Changed I <sub>CCI</sub> and I <sub>CCZ</sub> values From: BD Changed I <sub>CCI</sub> and I <sub>CCZ</sub> values From: BD Changed I <sub>CCI</sub> and I <sub>CCZ</sub> values From: BD Changed I <sub>CCI</sub> and I <sub>CCZ</sub> values From: BD Changed Typical value from 1 To: 2 10 Changed Typical value from 1 To: 2 11 Changed Typical value from 1 To: 2 10 Changed Typical value from 1 To: 2 11 Changed Typical value from 1 To: 2 12 Changed Typical value from 1 To: 2 13 Changed Typical value from 1 To: 2 14 Changed Typical value from 1 To: 2 15 Changed Typical value from 1 To: 2 16 Changed Typical value from 1 To: 2 17 Changed Typical value from 1 To: 2 18 Changed Typical value from 1 To: 2 19 Changed Typical value from 1 To: 2 10	•	Deleted text from paragraph 2 of the Description: "and turns off internal bias circuitry to conserve power"	1
Changed V <sub>CC</sub> From: 3.6 To: 3.45 Changed V <sub>CC</sub> alues From: TBD 4 Changed V <sub>CC</sub> - 0.4 To: V <sub>CC</sub> - 0.8 4 Changed V <sub>CC</sub> - 0.4 To: V <sub>CC</sub> - 0.8 4 Changed Typical value from 1 To: 2 4 Changed Propagation delay max From: 80 To: 95 4 Changed Propagation delay max From: 80 To: 95 4 Changed I <sub>CC1</sub> and I <sub>CC2</sub> values From: TBD 5 Changed Propagation delay max From: 80 To: 100 5 Changed Propagation delay max From: 80 To: 100 6 Changed Propagation delay max From: 80 To: 100 6 Changed Propagation delay max From: 80 To: 100 6 Changed Propagation delay max From: 80 To: 100 6 Changed Propagation delay max From: 80 To: 100 7 Changed Propagation delay max From: 80 To: 100 7 Changed Propagation delay max From: 80 To: 100 7 Changed Propagation delay max From: 80 To: 100 7 Changed Propagation delay max From: 85 To: 110 7 Changed Propagation delay max From: 85 To: 110 7 Changed Typical value from 1 To: 2 10 Changed Typical value from 1 To: 2 10 Changed Typical value from 1 To: 2 10 Changed He REGULATORY INFORMATION Table 10 Changed Figure 11 11 Changes from Revision A (June 2008) to Revision B Page Changed From Revision B (July 2008) to Revision C Page Changed "Ins" to "2ns", added "(5v-Operation)" 10 Deleted Min = 4.5 V and max = 5.5 V for Supply Voltage of the ROC Table. 3 Changed Figure 1 1 10 Changed Figure 1 10 Corrected DEVICE I/O SCHEMATICS	•	Deleted Product Preview note	2
Changed I <sub>CCI</sub> and I <sub>CC2</sub> values From: TBD	•	Changed From: 3 To: 3.15	3
Changed V <sub>CC</sub> = 0.4 To: V <sub>CC</sub> = 0.8	•	Changed V <sub>CC</sub> From: 3.6 To: 3.45	3
Changed Typical value from 1 To: 2	•	Changed I <sub>CC1</sub> and I <sub>CC2</sub> values From: TBD	4
Changed Propagation delay max From: 80 To: 95	•	Changed V <sub>CC</sub> – 0.4 To: V <sub>CC</sub> – 0.8	4
Changed I <sub>CC1</sub> and I <sub>CC2</sub> values From: TBD	•	Changed Typical value from 1 To: 2	4
Changed Typical value from 1 To: 2	•	Changed Propagation delay max From: 80 To: 95	4
<ul> <li>Changed Propagation delay max From: 80 To: 100</li></ul>	•	Changed I <sub>CC1</sub> and I <sub>CC2</sub> values From: TBD	5
<ul> <li>Changed I<sub>CC1</sub> and I<sub>CC2</sub> values From: TBD</li></ul>	•	Changed Typical value from 1 To: 2	5
Changed Typical value from 1 To: 2	•	Changed Propagation delay max From: 80 To: 100	5
<ul> <li>Changed Propagation delay max From: 80 To: 100</li></ul>	•	Changed I <sub>CC1</sub> and I <sub>CC2</sub> values From: TBD	6
<ul> <li>Changed I<sub>CC1</sub> and I<sub>CC2</sub> values From: TBD</li> <li>Changed</li> <li>Changed</li></ul>	•	Changed Typical value from 1 To: 2	6
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<ul> <li>Changed Typical value from 1 To: 2</li></ul>	•	Changed I <sub>CC1</sub> and I <sub>CC2</sub> values From: TBD	<b>7</b>
<ul> <li>Changed Propagation delay max From: 85 To: 110</li></ul>	•	Changed	<mark>7</mark>
<ul> <li>Changed L(101) Minimum air gap (Clearance) - minimum value from: 7.7mm to: 8.34mm</li> <li>Changed Typical value from 1 To: 2</li> <li>Changed Typical value from 1 To: 2</li> <li>Changed the REGULATORY INFORMATION Table</li> <li>Changed Figure 11</li> <li>Changed Figure 11</li> <li>Changes from Revision A (June 2008) to Revision B</li> <li>Changed V<sub>CC</sub> From: 3.45 To: 3.6</li> <li>Changes from Revision B (July 2008) to Revision C</li> <li>Page</li> <li>Changed "1ns" to "2ns", added "(5v-Operation)"</li> <li>Changed "2ns" to "10ns", added "(5v-Operation)"</li> <li>Deleted "Low Jitter Content; 1 ns Typ at 150 Mbps"</li> <li>Deleted Min = 4.5 V and max = 5.5 V for Supply Voltage of the ROC Table</li> <li>Changed Figure 1</li> <li>Changed Figure 1</li> <li>Changed Figure 1</li> <li>Changed File number "1698195" to "220991"</li> <li>Corrected DEVICE I/O SCHEMATICS</li> <li>Corrected DEVICE I/O SCHEMATICS</li> </ul>	•	Changed Typical value from 1 To: 2	<mark>7</mark>
<ul> <li>Changed Typical value from 1 To: 2</li></ul>	•	Changed Propagation delay max From: 85 To: 110	<mark>7</mark>
<ul> <li>Changed Typical value from 1 To: 2</li></ul>	•	Changed L(101) Minimum air gap (Clearance) - minimum value from: 7.7mm to: 8.34mm	10
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• Changed Figure 11       13         Changes from Revision A (June 2008) to Revision B       Page         • Changed V <sub>CC</sub> From: 3.45 To: 3.6       3         Changes from Revision B (July 2008) to Revision C       Page         • Changed "1ns" to "2ns", added "(5v-Operation)"       1         • Changed "2ns" to "10ns", added "(5v-Operation)"       1         • Deleted "Low Jitter Content; 1 ns Typ at 150 Mbps"       1         • Deleted Min = 4.5 V and max = 5.5 V for Supply Voltage of the ROC Table.       3         • Changed V <sub>CC</sub> From: 3.6 To: 5.5       3         • Corrected Figure 1       8         • Changed File number "1698195" to "220991"       10         • Corrected DEVICE I/O SCHEMATICS       10	•	Changed Typical value from 1 To: 2	10
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<ul> <li>Changed "2ns" to "10ns", added "(5v-Operation)"</li></ul>	•	Changed "1ns" to "2ns", added "(5v-Operation)"	1
<ul> <li>Deleted "Low Jitter Content; 1 ns Typ at 150 Mbps"</li></ul>			
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6-Feb-2020

#### PACKAGING INFORMATION

Orderable Device	Status	Package Type	Package Drawing	Pins	Package Qty	Eco Plan	Lead/Ball Finish	MSL Peak Temp	Op Temp (°C)	Device Marking (4/5)	Samples
ISO7230ADW	NRND	SOIC	DW	16	40	Green (RoHS & no Sb/Br)	NIPDAU	Level-2-260C-1 YEAR	-40 to 125	ISO7230A	
ISO7230ADWG4	NRND	SOIC	DW	16	40	Green (RoHS & no Sb/Br)	NIPDAU	Level-2-260C-1 YEAR	-40 to 125	ISO7230A	
ISO7230ADWR	NRND	SOIC	DW	16	2000	Green (RoHS & no Sb/Br)	NIPDAU	Level-2-260C-1 YEAR	-40 to 125	ISO7230A	
ISO7231ADW	NRND	SOIC	DW	16	40	Green (RoHS & no Sb/Br)	NIPDAU	Level-2-260C-1 YEAR	-40 to 125	ISO7231A	
ISO7231ADWR	NRND	SOIC	DW	16	2000	Green (RoHS & no Sb/Br)	NIPDAU	Level-2-260C-1 YEAR	-40 to 125	ISO7231A	

(1) The marketing status values are defined as follows:

ACTIVE: Product device recommended for new designs.

LIFEBUY: TI has announced that the device will be discontinued, and a lifetime-buy period is in effect.

NRND: Not recommended for new designs. Device is in production to support existing customers, but TI does not recommend using this part in a new design.

PREVIEW: Device has been announced but is not in production. Samples may or may not be available.

**OBSOLETE:** TI has discontinued the production of the device.

(2) RoHS: TI defines "RoHS" to mean semiconductor products that are compliant with the current EU RoHS requirements for all 10 RoHS substances, including the requirement that RoHS substance do not exceed 0.1% by weight in homogeneous materials. Where designed to be soldered at high temperatures, "RoHS" products are suitable for use in specified lead-free processes. TI may reference these types of products as "Pb-Free".

RoHS Exempt: TI defines "RoHS Exempt" to mean products that contain lead but are compliant with EU RoHS pursuant to a specific EU RoHS exemption.

**Green:** TI defines "Green" to mean the content of Chlorine (Cl) and Bromine (Br) based flame retardants meet JS709B low halogen requirements of <=1000ppm threshold. Antimony trioxide based flame retardants must also meet the <=1000ppm threshold requirement.

- (3) MSL, Peak Temp. The Moisture Sensitivity Level rating according to the JEDEC industry standard classifications, and peak solder temperature.
- (4) There may be additional marking, which relates to the logo, the lot trace code information, or the environmental category on the device.
- (5) Multiple Device Markings will be inside parentheses. Only one Device Marking contained in parentheses and separated by a "~" will appear on a device. If a line is indented then it is a continuation of the previous line and the two combined represent the entire Device Marking for that device.
- (6) Lead/Ball Finish Orderable Devices may have multiple material finish options. Finish options are separated by a vertical ruled line. Lead/Ball Finish values may wrap to two lines if the finish value exceeds the maximum column width.



## **PACKAGE OPTION ADDENDUM**

6-Feb-2020

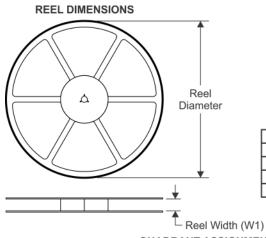
**Important Information and Disclaimer:** The information provided on this page represents TI's knowledge and belief as of the date that it is provided. TI bases its knowledge and belief on information provided by third parties, and makes no representation or warranty as to the accuracy of such information. Efforts are underway to better integrate information from third parties. TI has taken and continues to take reasonable steps to provide representative and accurate information but may not have conducted destructive testing or chemical analysis on incoming materials and chemicals. TI and TI suppliers consider certain information to be proprietary, and thus CAS numbers and other limited information may not be available for release.

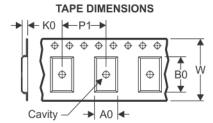
In no event shall TI's liability arising out of such information exceed the total purchase price of the TI part(s) at issue in this document sold by TI to Customer on an annual basis.

PACKAGE MATERIALS INFORMATION

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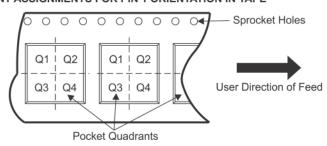
## TAPE AND REEL INFORMATION





A0	Dimension designed to accommodate the component width
B0	Dimension designed to accommodate the component length
K0	Dimension designed to accommodate the component thickness
W	Overall width of the carrier tape
P1	Pitch between successive cavity centers

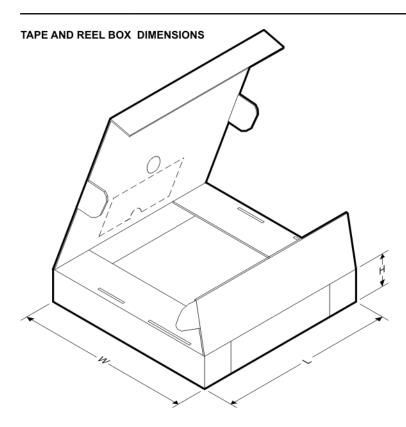
## QUADRANT ASSIGNMENTS FOR PIN 1 ORIENTATION IN TAPE



#### \*All dimensions are nominal

Device	Package Type	Package Drawing		SPQ	Reel Diameter (mm)	Reel Width W1 (mm)	A0 (mm)	B0 (mm)	K0 (mm)	P1 (mm)	W (mm)	Pin1 Quadrant
ISO7230ADWR	SOIC	DW	16	2000	330.0	16.4	10.75	10.7	2.7	12.0	16.0	Q1
ISO7231ADWR	SOIC	DW	16	2000	330.0	16.4	10.75	10.7	2.7	12.0	16.0	Q1

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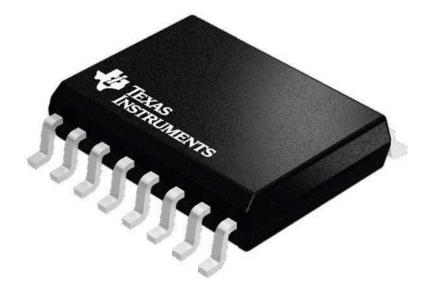
#### \*All dimensions are nominal

Device	Package Type	Package Drawing	Pins	SPQ	Length (mm)	Width (mm)	Height (mm)
ISO7230ADWR	SOIC	DW	16	2000	350.0	350.0	43.0
ISO7231ADWR	SOIC	DW	16	2000	350.0	350.0	43.0

7.5 x 10.3, 1.27 mm pitch

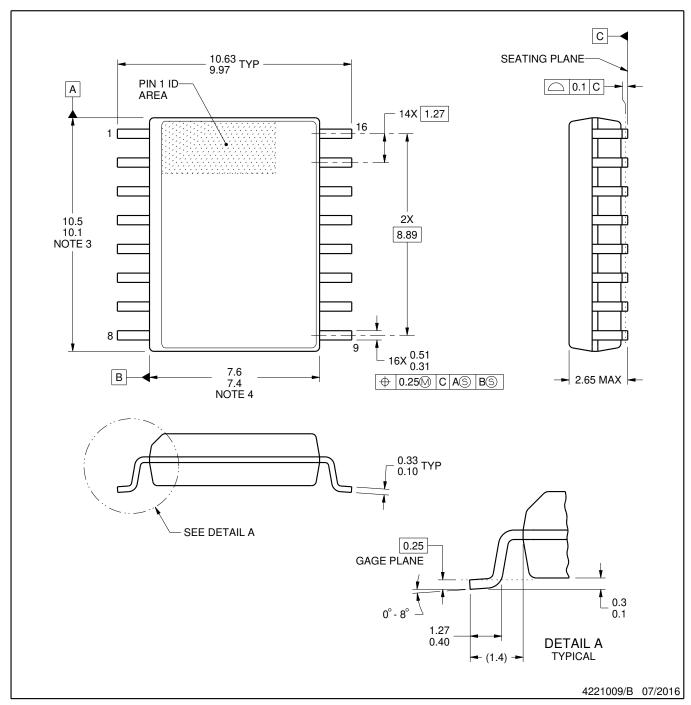
SMALL OUTLINE INTEGRATED CIRCUIT

This image is a representation of the package family, actual package may vary. Refer to the product data sheet for package details.





SOIC



#### NOTES:

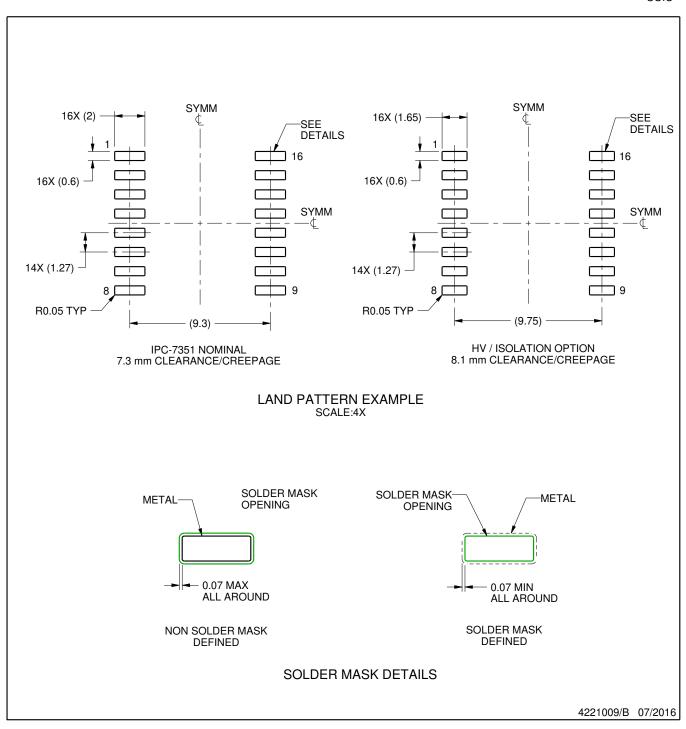
- 1. All linear dimensions are in millimeters. Dimensions in parenthesis are for reference only. Dimensioning and tolerancing
- per ASME Y14.5M.

  2. This drawing is subject to change without notice.

  3. This dimension does not include mold flash, protrusions, or gate burrs. Mold flash, protrusions, or gate burrs shall not exceed 0.15 mm, per side.
- 4. This dimension does not include interlead flash. Interlead flash shall not exceed 0.25 mm, per side.
- 5. Reference JEDEC registration MS-013.



SOIC



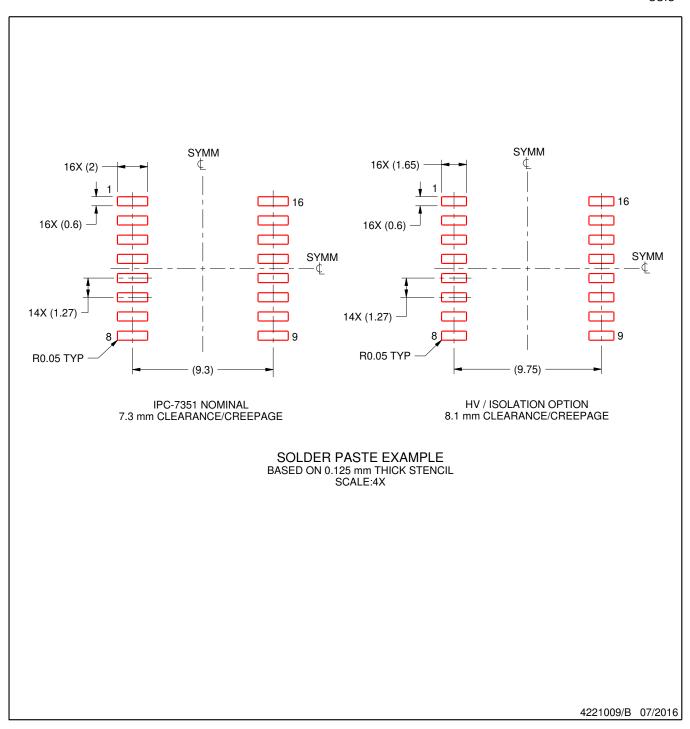
#### NOTES: (continued)

6. Publication IPC-7351 may have alternate designs.

7. Solder mask tolerances between and around signal pads can vary based on board fabrication site.



SOIC



#### NOTES: (continued)

- 8. Laser cutting apertures with trapezoidal walls and rounded corners may offer better paste release. IPC-7525 may have alternate design recommendations.
- 9. Board assembly site may have different recommendations for stencil design.



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